Search Notes		
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/617,835	MEYER ET AL.	
Examiner	Art Unit	
Sumesh Kaushal Ph.D.	1633	

	SEAR	CHED	
Class	Subclass	Date	Examiner
435	69.1 320.1 325 455 243 252.1 471	8/31/2005	SK
536	23.1 23.7	8/31/2005	SK
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INT	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	DATE	EXMR
STN: Medline, Caplus, Scisearch, Cancerlit, Mediconf. EAST: USPAT, PGPUB, EPO, JPO, DERWENT. STIC Sequence search report. Inventor name search. see attachment.	8/31/2005	sκ